



Si3812DV

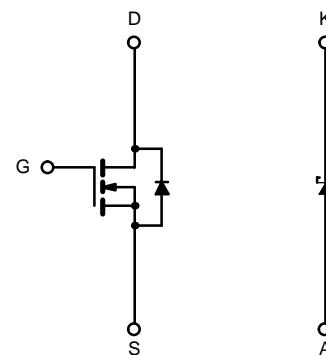
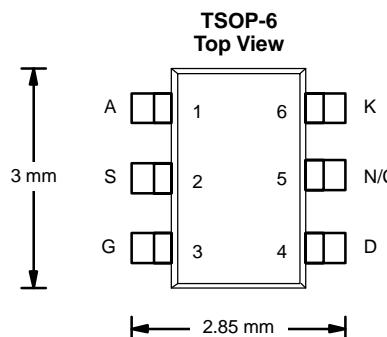
Vishay Siliconix

N-Channel 20-V (D-S) MOSFET With Schottky Diode

LITTLE FOOTTM Plus

MOSFET PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
20	0.125 @ $V_{GS} = 4.5$ V	± 2.4
	0.200 @ $V_{GS} = 2.5$ V	± 1.8

SCHOTTKY PRODUCT SUMMARY		
V_{KA} (V)	V_f (V) Diode Forward Voltage	I_F (A)
20	0.48 V @ 0.5 A	0.5



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C UNLESS OTHERWISE NOTED)						
Parameter		Symbol	5 sec	Steady State	Unit	
Drain-Source Voltage (MOSFET)		V_{DS}	20		V	
Reverse Voltage (Schottky)		V_{KA}	20			
Gate-Source Voltage (MOSFET)		V_{GS}	± 12	± 12		
Continuous Drain Current (T _J = 150°C) (MOSFET) ^a	T _A = 25°C	I_D	± 2.4	± 2.0	A	
	T _A = 85°C		± 1.7	± 1.4		
Pulsed Drain Current (MOSFET)		I_{DM}	± 8			
Continuous Source Current (MOSFET Diode Conduction) ^a		I_S	1.05	0.75		
Average Foward Current (Schottky)		I_F	0.5	0.5		
Pulsed Foward Current (Schottky)		I_{FM}	8	8		
Maximum Power Dissipation (MOSFET) ^a	T _A = 25°C	P_D	1.15	0.83	W	
	T _A = 85°C		0.59	0.53		
Maximum Power Dissipation (Schottky) ^a	T _A = 25°C		1.0	0.76		
	T _A = 85°C		0.52	0.48		
Operating Junction and Storage Temperature Range		T_J , T_{stg}	-55 to 150		°C	

Notes

a. Surface Mounted on 1" x 1" FR4 Board.

THERMAL RESISTANCE RATINGS

Parameter	Device	Symbol	Typical	Maximum	Unit
Junction-to-Ambient ^a	t ≤ 5 sec	MOSFET	R _{thJA}	93	110
		Schottky		103	125
Junction-to-Ambient ^a	Steady State	MOSFET		130	150
		Schottky		140	165
Junction-to-Foot (MOSFET Drain, Schottky Cathode)	Steady State	MOSFET	R _{thJF}	75	90
		Schottky		80	95

Notes

a. Surface Mounted on 1" x1" FR4 Board.

MOSFET + SCHOTTKY SPECIFICATIONS (T_J = 25°C UNLESS OTHERWISE NOTED)

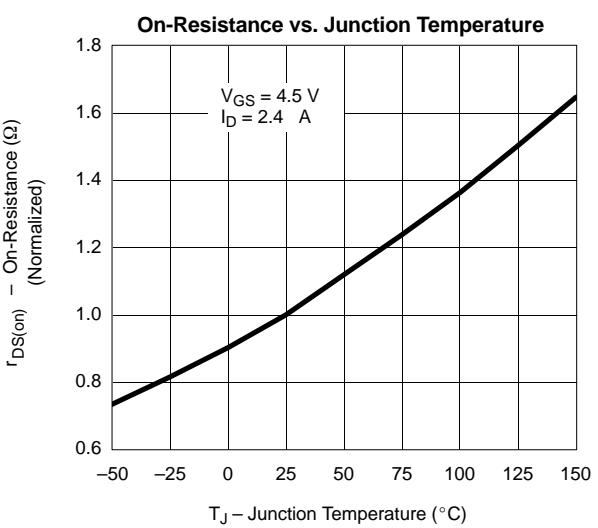
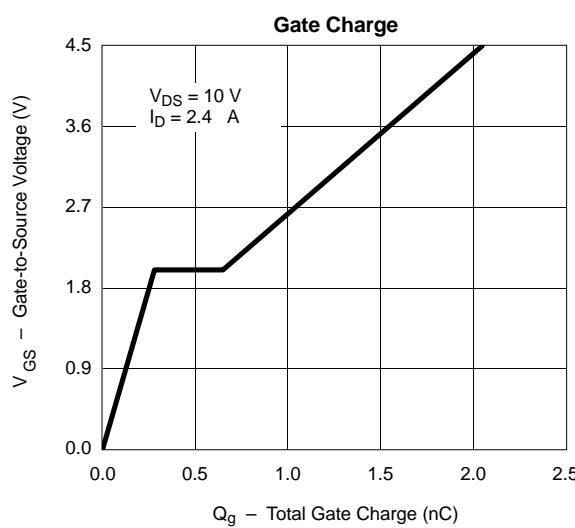
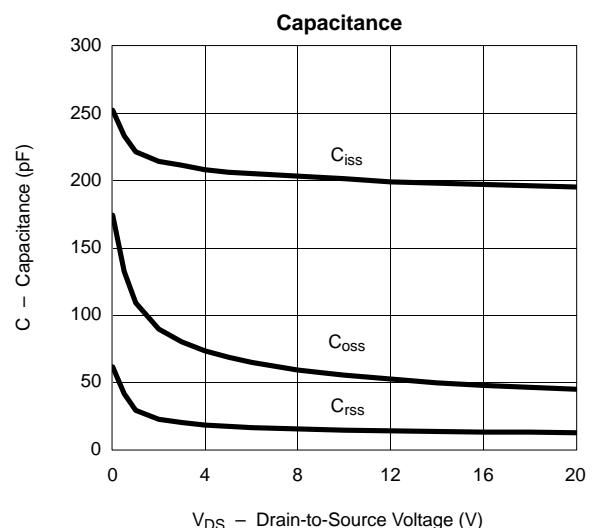
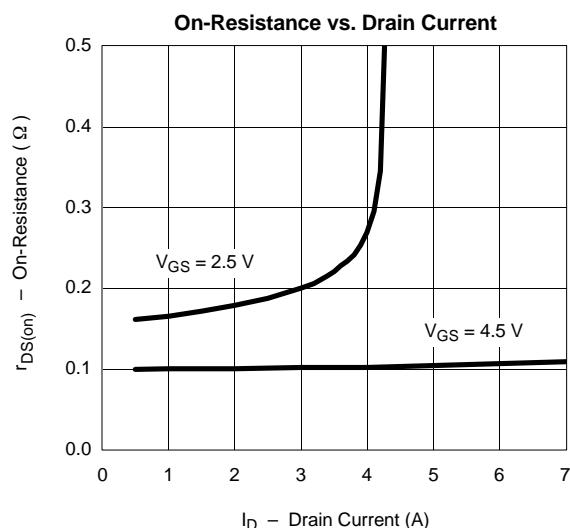
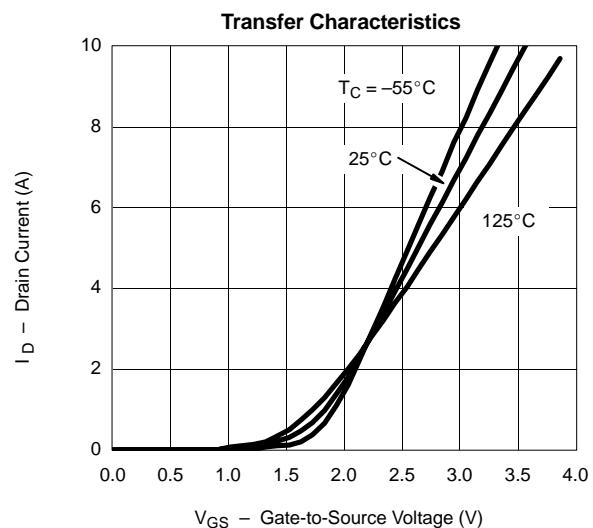
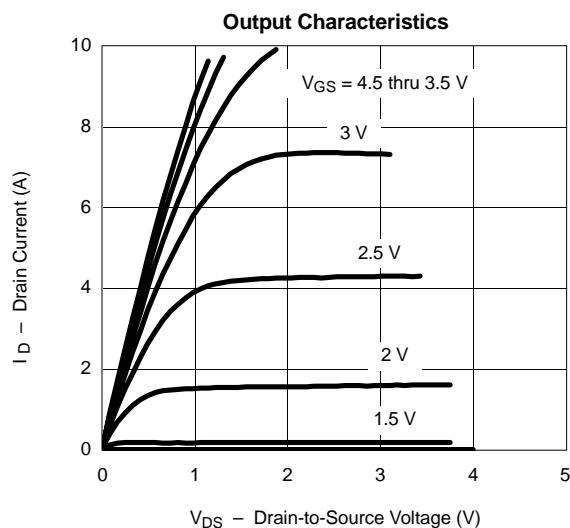
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	0.6			V
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±12 V			±100	nA
Zero Gate Voltage Drain Current (MOSFET + Schottky)	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V			1	μA
		V _{DS} = 16 V, V _{GS} = 0 V, T _J = 85°C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 4.5 V	5			A
Drain-Source On-State Resistance ^a	r _{D(on)}	V _{GS} = 4.5 V, I _D = 2.4 A		0.100	0.125	Ω
		V _{GS} = 2.5 V, I _D = 1.0 A		0.160	0.200	
Forward Transconductance ^a	g _f	V _{DS} = 5 V, I _D = 2.4 A		5		S
Schottky Diode Forward Voltage ^a	V _{SD}	I _S = 1.5 A, V _{GS} = 0 V		0.79	1.1	V
Dynamic^b						
Total Gate Charge	Q _g	V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 2.4 A		2.1	4.0	nC
Gate-Source Charge	Q _{gs}			0.3		
Gate-Drain Charge	Q _{gd}			0.4		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 10 V, R _L = 10 Ω I _D ≈ 1 A, V _{GEN} = 4.5 V, R _G = 6 Ω		10	17	ns
Rise Time	t _r			30	50	
Turn-Off Delay Time	t _{d(off)}			14	25	
Fall Time	t _f			6	12	
Source-Drain Reverse Recovery Time	t _{rr}		I _F = 3.0 A, di/dt = 100 A/μs	30	50	

Notes

- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%.
 b. Guaranteed by design, not subject to production testing.

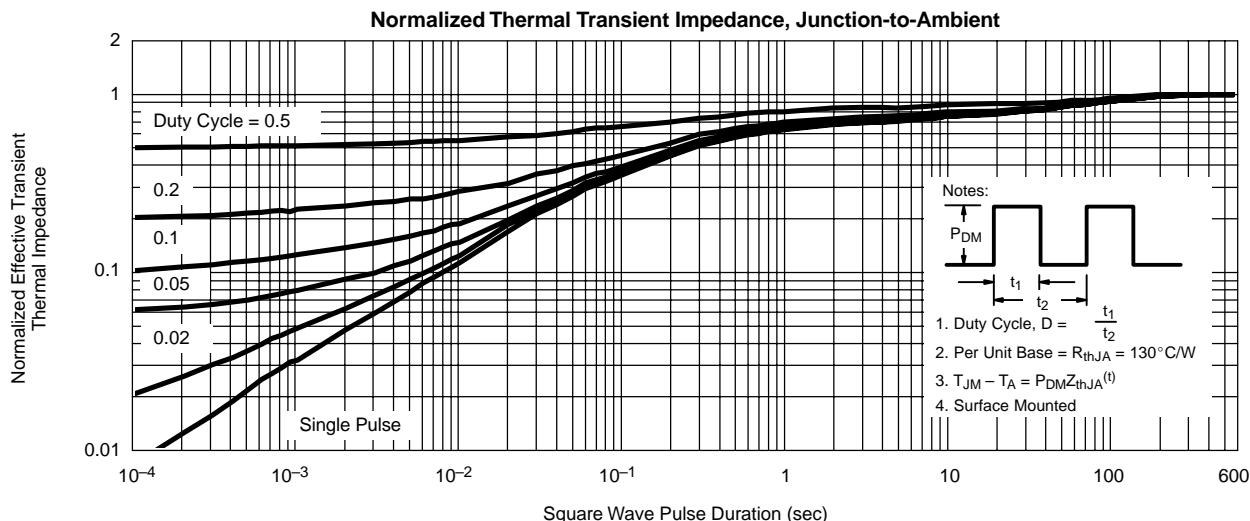
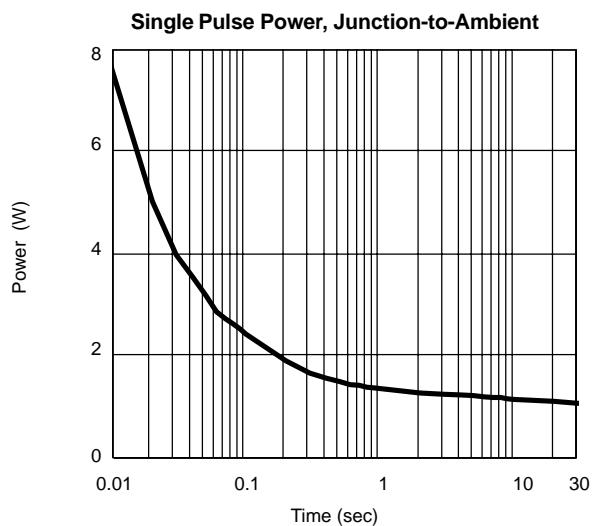
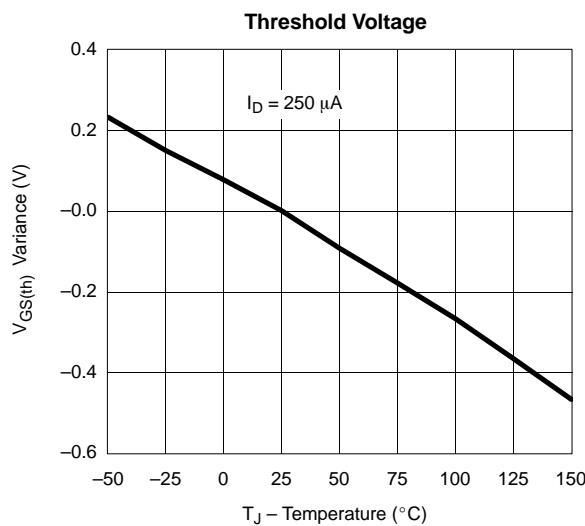
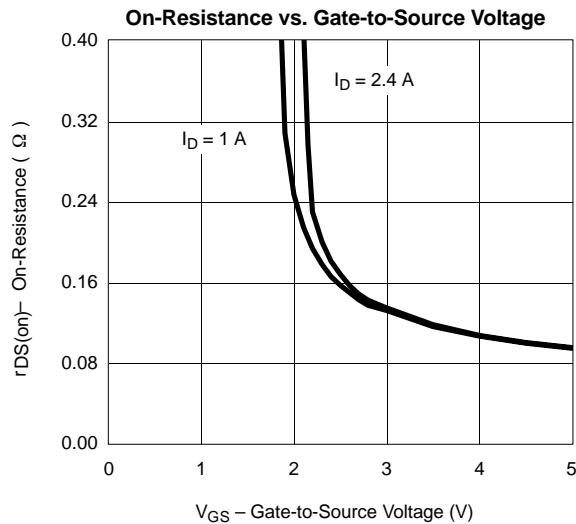
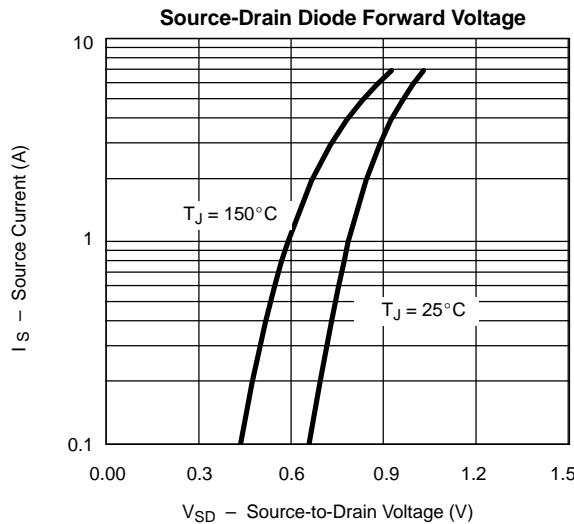
SCHOTTKY SPECIFICATIONS (T_J = 25°C UNLESS OTHERWISE NOTED)

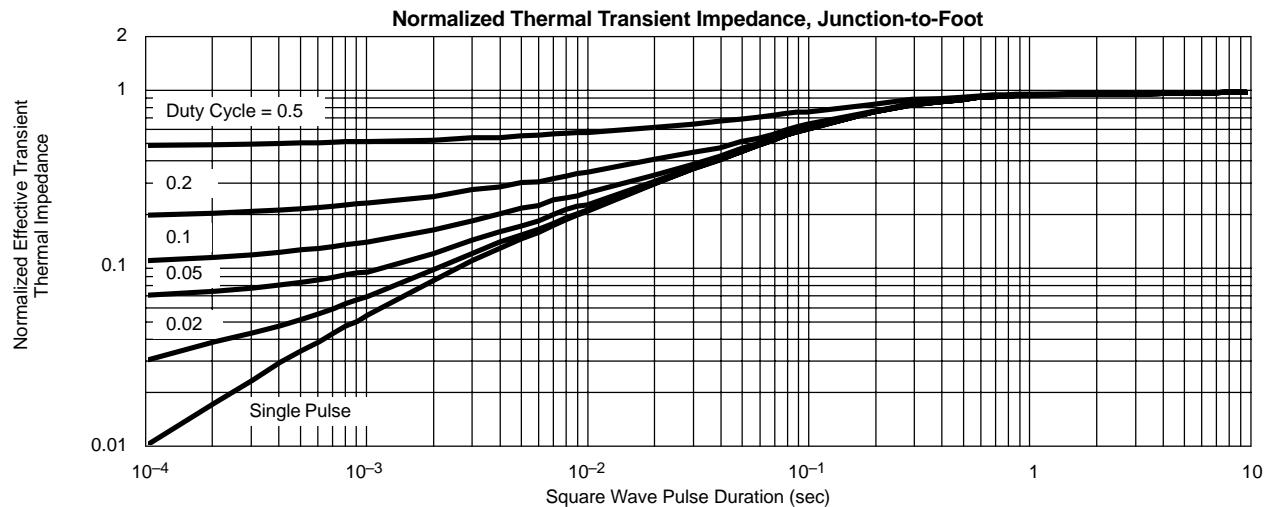
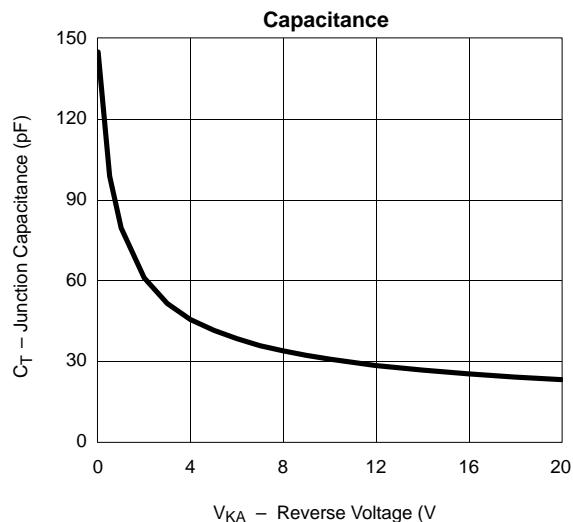
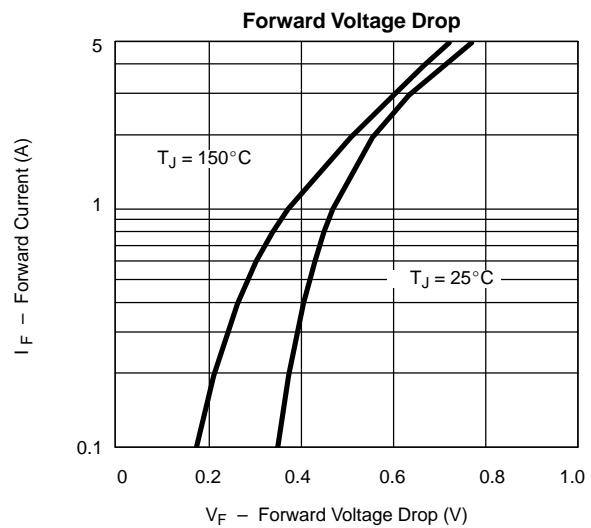
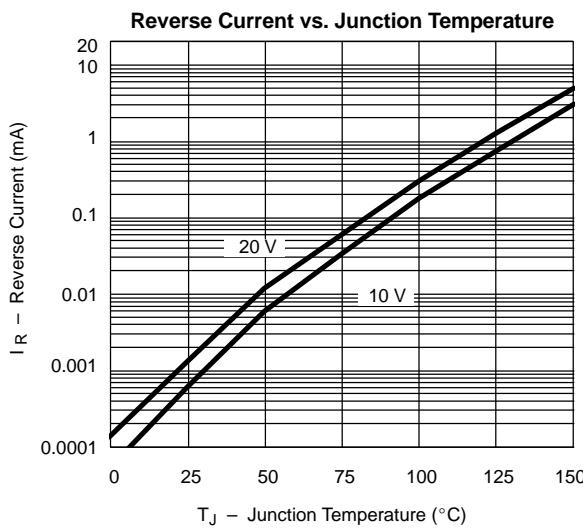
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Forward Voltage Drop	V _F	I _F = 0.5		0.42	0.48	V
		I _F = 0.5, T _J = 125°C		0.33	0.4	
Maximum Reverse Leakage Current	I _{rm}	V _r = 20		0.002	0.100	mA
		V _r = 20, T _J = 75°C		0.06	1	
		V _r = 20, T _J = 125°C		1.5	10	
Junction Capacitance	C _T	V _r = 10 V		31		pF

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)
MOSFET


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